

Notice of References Cited	Application/Control No. 10/701,075	Applicant(s)/Patent Under Reexamination HOK ET AL.	
	Examiner Michael Cygan	Art Unit 2855	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0043423	03-2004	Bellew et al.	435/007.1
	B	US-6,378,372	04-2002	Karr, Lawrence J.	73/579
	C	US-5,363,691	11-1994	Gallagher, John G.	73/32A
	D	US-3,953,734	04-1976	Dimeff, John	250/343
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP-538,235-A1	09-1992	EPO	Leopold et al.	
	O	GB-2,288,660-A	10-1995	GBX	Melch Fischer	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Granstedt et al. "New CO2 Sensor With High Resolution and Fast Response", 2001 Proceedings of the 23rd Annual EMBS International Conference, October 25-28, Istanbul, Turkey.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.